

Search Notes

Application/Control No.

10/692,093

Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

BIAN, JINRU

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Performed inventor search for double patenting (PALM, eDAN)	6/24/2005	EC
EAST (all databases) - See Search History Printout	6/24/2005	EC
438/690-692; 216/88-91; 252/79.1; 510/175-176 (text search only - see search history printout) (consulted Shamim Ahmed)	6/24/2005	EC